Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/710,657	GUO ET AL.	
Examiner	Art Unit	-
David Mis	2817	

SEARCHED			
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Class	Subclass	Date	Examiner
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Class	Subclass	Date	Examiner
USPGPUB	(see	10/13/2005	DM
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